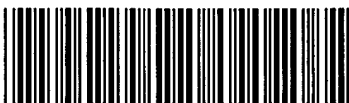


Search Notes

Application/Control No.

10/803,223

Examiner

Audrey Y. Chang

Applicant(s)/Patent under
Reexamination

KITAGAWA, HITOSHI

Art Unit

2872

SEARCHED

| Class | Subclass | Date | Examiner |
|-------|----------|-----------|----------|
| 359 | 582 | 9/19/2005 | AC |
| 359 | 584 | 9/19/2005 | AC |
| | | | |
| | | | |
| | | | |
| | | | |
| | | | |
| | | | |
| | | | |
| | | | |
| | | | |
| | | | |
| | | | |
| | | | |
| | | | |

INTERFERENCE SEARCHED

| Class | Subclass | Date | Examiner |
|-------|----------|------|----------|
| | | | |
| | | | |
| | | | |
| | | | |

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

| | DATE | EXMR |
|-----------------------------|-----------|------|
| EAST (search note included) | 5/19/2005 | AC |
| Google, Applied Optics | 5/19/2005 | AC |
| | | |
| | | |
| | | |
| | | |
| | | |
| | | |
| | | |
| | | |
| | | |
| | | |
| | | |
| | | |